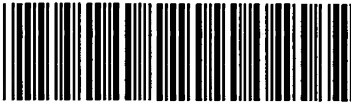


**Search Notes**

Application/Control No.

10/645,525

Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

MASSASSO ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	all with text	11/25/2006	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	text	11/25/2006	LEE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search attached	11/26/2006	LEE